

Features

- · 3rd generation SiC MOSFET technology
- · Optimized package with separate driver source pin
- High blocking voltage with low on-resistance
- · High-speed switching with low capacitances
- · Fast intrinsic diode with low reverse recovery (Qrr)
- · Halogen free, RoHS compliant

Benefts

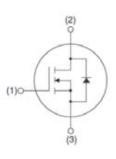
- · Reduce switching losses and minimize gate ringing
- · Higher system effciency
- · Reduce cooling requirements
- · Increase power density
- Increase system switching frequency

Applications

- · Renewable energy
- · EV battery chargers
- · High voltage DC/DC converters
- Switch Mode Power Supplies





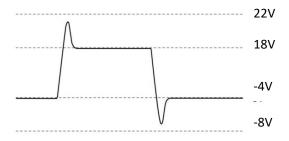


Ordering Part Number	Package	Marking	
HC3M00160120D	TO-247	HC3M00160120D	

Maximum Ratings (Tc = 25 °C unless otherwise specifed)

Parameter	Symbol	Value	Unit
Drain-source voltage	Vds	1200	V
Continuous drain current Tc = 25°C Tc = 100°C	lo	17 12	A
Pulsed drain current (Tc = 25°C, t_P limited by T_{jmax})	D pulse	34	А
Avalanche energy, single pulse (L=10mH)	Eas	1000	mJ
Gate-Source voltage	Vgs	-4/+18	V
Gate-Source voltage (dynamic,Absolute maximum values)	VGSmax	-8/+22	V
Power dissipation (Tc = 25° C)	Ptot	116	W
Operating junction and storage temperature	Tj,Tstg	-55+175	°C

• Example of acceptable Vgs waveform



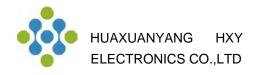


Thermal Resistance

Parameter	Symbol	Value	Unit
Thermal resistance, junction – case. Max	RthJC	1.29	°C/W
Thermal resistance, junction – ambient. Max	RthJA	40	0/11

Electrical Characteristic (at Tj = 25 °C, unless otherwise specified)

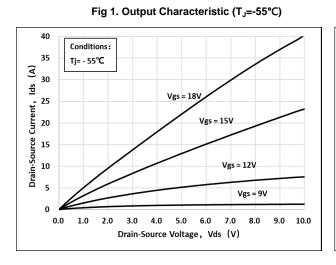
Parameter	Symbol		Value		Unit	Test Condition
Parameter	Symbol	min.	typ.	max.	Unit	Test Condition
Static Characteristic						
Drain-source breakdown voltage	BVDSS	1200	-	-	V	Vgs=0V, Id=100uA
Gate threshold voltage	VGS(th)	2	3.1	4	V	VDS=VGS,ID=2.3mA
Zero gate voltage drain current	ldss	-	1 5	20 -	μA	VDS=1200V,VGS=0V Tj=25°C Tj=175°C
Gate-source leakage current	lgss	-		200	nA	Vgs=18V,Vds=0V
Drain-source on-state resistance	RDS(on)	-	160 250	208 -	m	V₀s=8V,I⊵=8A, Tj=25°C Tj=175°C
Transconductance	g fs	-	5	-	S	VDS=20V,ID=40A
Dynamic Characteristic						
Input Capacitance	Ciss	-	624	-		Vps = 1000V
Output Capacitance	Coss	-	42	-	рF	Vgs = 0V TJ = 25°C
Reverse Transfer Capacitance	Crss	-	6	-		V _{AC} = 25mV f = 1MHz
Gate Total Charge	QG	-	37.4	-		Vds = 800V
Gate-Source charge	Qgs	-	5.3	-	nC	$V_{GS} = -0/18V$
Gate-Drain charge	Q _{gd}	-	20.6	-		I _D =8A I _G =10mA
Turn-On Switching Energy	Eon	-	11	-	1	
Turn-Off Switching Energy-	EOFF	-	230		μJ	Vdd = 800V
Turn-on delay time	td(on)	-	12.25	-		Vgs = -4/+18V Id =8A
Rise time	tr	-	18.68	-		Rg = 5
Turn-off delay time	td(off)	-	17.37	-	ns	L = 120uH
Fall time	tr	-	11.82	-	1	
Gate resistance	Rg	-	3.3	-		Vac = 25mV, f=1MHz



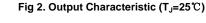
Body Diode Characteristic

Parameter	Symbol Value Unit Test Condit	Test Condition				
i alametei	Symbol	min.	typ.	max.	Unit	rest condition
	Vsd	3.6	V	Vgs=0V,Isd=40A, Tj=25°C		
Body Diode Forward Voltage	3.2		V	Vgs=0V,Isd=40A, Tj=175°C		
Body Diode Reverse Recovery Time	trr	-	13.5	-	ns	V _R = 400V, I _D = 8A
Body Diode Reverse Recovery Charge	Qrr	-	36.8	-	nC	di/dt = 1000A/µS TJ=25°C





Typical Performance Characteristics



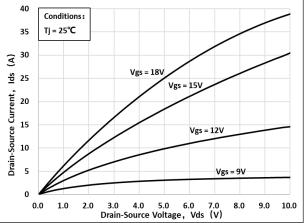
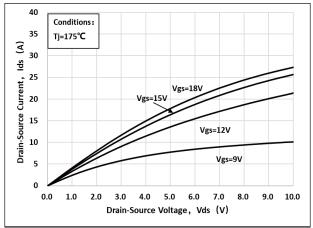
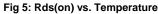


Fig 3. Output Characteristic (T_J=175°C)





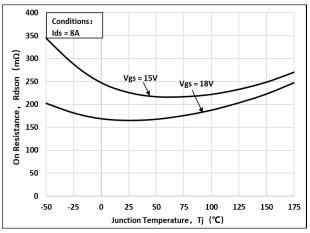
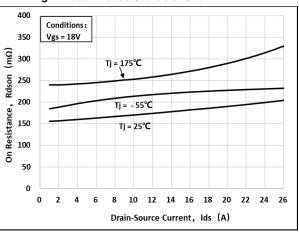
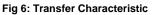
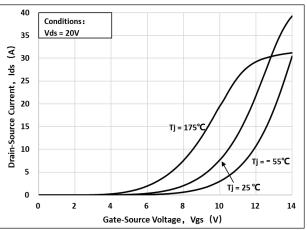
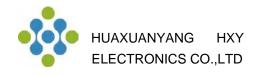


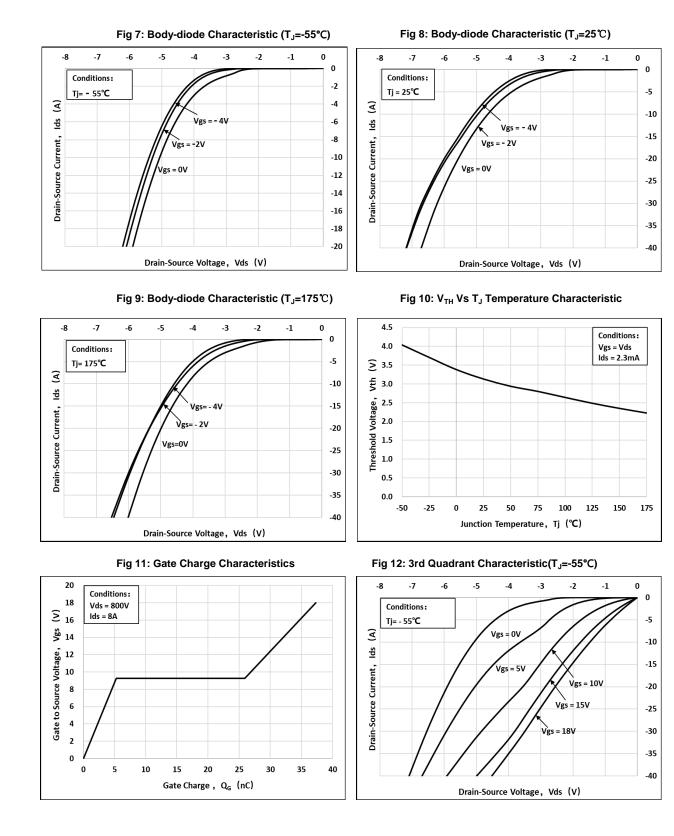
Fig 4: Rdson Vs Ids Characteristic













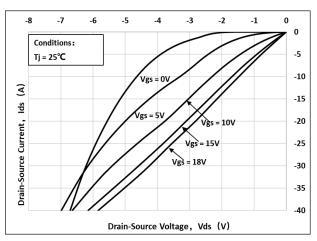


Fig 13: 3rd Quadrant Characteristic(T_=25°C)

Fig 14: 3rd Quadrant Characteristic(T_J=175℃)

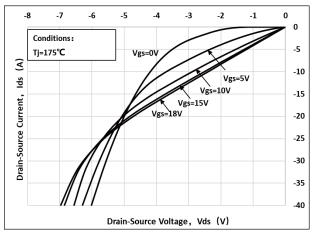
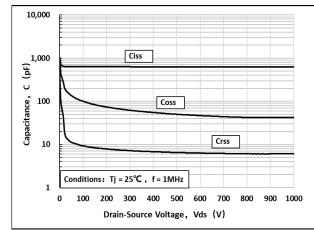


Fig 15: Capacitance Characteristic





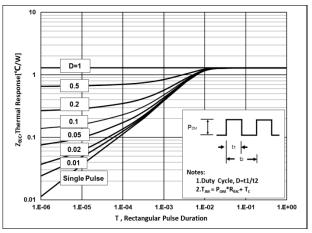
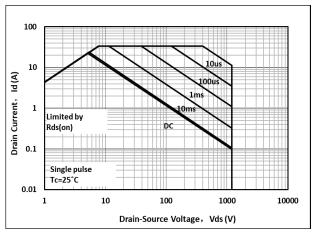


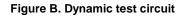
Fig 16: Safe Operating Area

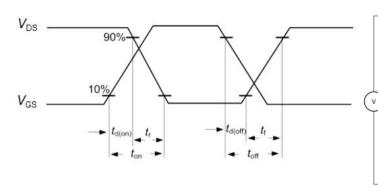




Test Circuit Schematic

Figure A. Definition of switching times





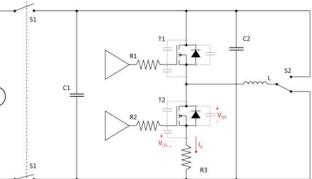


Figure C. Definition of body diodeswitching characteristics

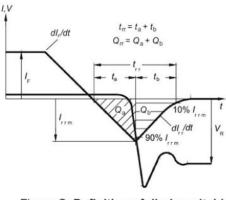
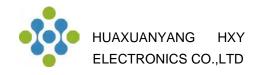
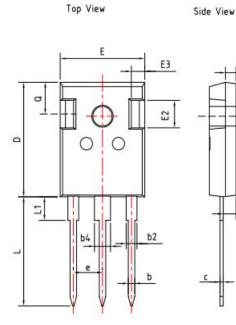


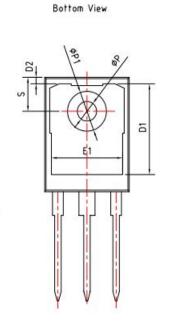
Figure C. Definition of diode switching characteristics



Package Dimensions

Package TO-247



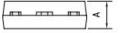


A2

A1

	Dimension unit:[mm]					
SYMBOL	MIN	NOM	MAX			
Α	4.80	5.00	5.20			
A1	2.21	2.41	2.61			
A2	1.85	2.00	2.15			
b	1.11	1.21	1.36			
b2	1.91	2.01	2.21			
b4	2.91	3.01	3.21			
c	0.51	0.60	0.75			
D	20.70	21.00	21.30			
D1 16.25		16.55	16.85			
D2	1.00	1.20	1.35			
E	15.50	15.80	16.10			
E1	13.00	13.30	13.60			
E2	4.80	5.00	5.20			
E3	2.30	2.50	2.70			
e		5.44 BSC				
L	19.62	19.92	20.22			
L1		-	4.30			
¢Ρ	3.40	3.60	3.80			
ØP1	-	-	7.30			
۵	5.40	5.80	6.20			
s		6.20 BSC				

Front View





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